

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/648,974 | Applicant(s)/Patent Under Reexamination HESSION ET AL. | |
| | Examiner LIEN TM NGO | Art Unit 3727 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,786,352 | 09-2004 | Belcastro, Domenic | 220/714 |
| | B | US-6,758,364 | 07-2004 | Rohrig, Peter | 220/714 |
| | C | US-6,568,557 | 05-2003 | Fusco et al. | 220/714 |
| | D | US-6,325,236 | 12-2001 | Wong, Chung Lun | 220/713 |
| | E | US-3,739,938 | 06-1973 | Paz, Nicolas S. | 220/715 |
| | F | US-6,471,101 | 10-2002 | Vardanyan, Gevorg | 222/541.2 |
| | G | US-6,305,570 | 10-2001 | Atkin et al. | 220/714 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.